

# High Voltage XPT™ IGBT w/ Diode

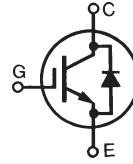
## IXYF30N170CV1

$$V_{CES} = 1700V$$

$$I_{C110} = 20A$$

$$V_{CE(sat)} \leq 4.0V$$

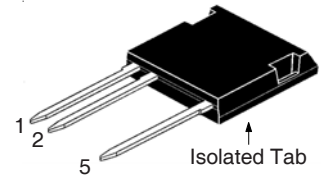
$$t_{fi(typ)} = 95ns$$



(Electrically Isolated Tab)

| Symbol                        | Test Conditions   | Maximum Ratings        |            |
|-------------------------------|---|------------------------|------------|
| $V_{CES}$                     | $T_J = 25^\circ C$ to $175^\circ C$   | 1700                   | V          |
| $V_{CGR}$                     | $T_J = 25^\circ C$ to $175^\circ C$ , $R_{GE} = 1M\Omega$                             | 1700                   | V          |
| $V_{GES}$                     | Continuous  | $\pm 20$               | V          |
| $V_{GEM}$                     | Transient   | $\pm 30$               | V          |
| $I_{C25}$                     | $T_C = 25^\circ C$  | 36                     | A          |
| $I_{C110}$                    | $T_C = 110^\circ C$   | 20                     | A          |
| $I_{F110}$                    | $T_C = 110^\circ C$   | 20                     | A          |
| $I_{CM}$                      | $T_C = 25^\circ C$ , 1ms  | 260                    | A          |
| <b>SSOA</b><br><b>(RBSOA)</b> | $V_{GE} = 15V$ , $T_{VJ} = 150^\circ C$ , $R_G = 2.7\Omega$<br>Clamped Inductive Load | $I_{CM} = 120$<br>1360 | A<br>V     |
| $P_C$                         | $T_C = 25^\circ C$  | 230                    | W          |
| $T_J$                         |   | -55 ... +175           | $^\circ C$ |
| $T_{JM}$                      |   | 175                    | $^\circ C$ |
| $T_{stg}$                     |   | -55 ... +175           | $^\circ C$ |
| $T_L$                         | Maximum Lead Temperature for Soldering  | 300                    | $^\circ C$ |
| $T_{SOLD}$                    | 1.6 mm (0.062in.) from Case for 10s   | 260                    | $^\circ C$ |
| $F_C$                         | Mounting Force  | 20..120 / 4.5..27      | Nm/lb.in.  |
| $V_{ISOL}$                    | 50/60Hz, 1 Minute   | 2500                   | V~         |
| <b>Weight</b>                 |   | 8                      | g          |

### ISOPLUS i4-Pak™



1 = Gate  
2 = Emitter  
5 = Collector

### Features

- Silicon Chip on Direct-Copper Bond (DCB) Substrate
- Isolated Mounting Surface
- 2500V~ Electrical Isolation
- High Blocking Voltage
- High Peak Current Capability
- Low Saturation Voltage

### Advantages

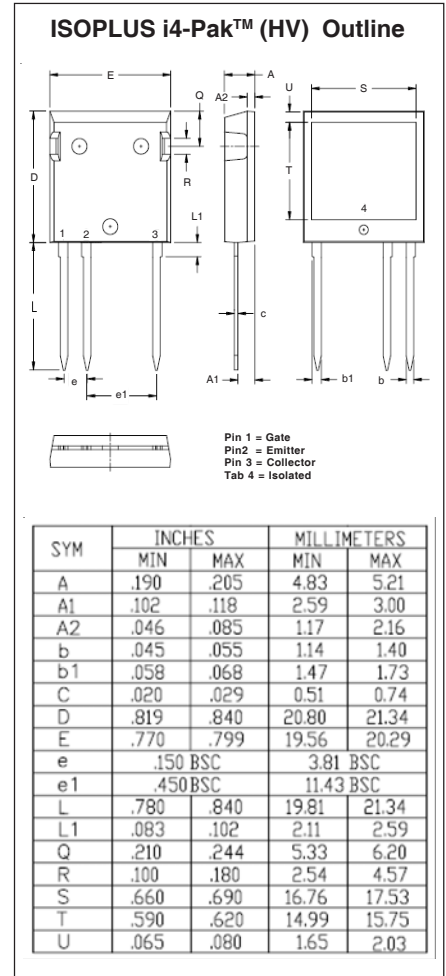
- Low Gate Drive Requirement
- High Power Density

### Applications

- Switch-Mode and Resonant-Mode Power Supplies
- Uninterruptible Power Supplies (UPS)
- Laser Generators
- Capacitor Discharge Circuits
- AC Switches

| Symbol        | Test Conditions<br>( $T_J = 25^\circ C$ , Unless Otherwise Specified)       | Characteristic Values |            |                    |
|---------------|---|-----------------------|------------|--------------------|
|               |   | Min.                  | Typ.       | Max.               |
| $BV_{CES}$    | $I_C = 250\mu A$ , $V_{GE} = 0V$  | 1700                  |            | V                  |
| $V_{GE(th)}$  | $I_C = 250\mu A$ , $V_{CE} = V_{GE}$  | 3.0                   |            | 5.0 V              |
| $I_{CES}$     | $V_{CE} = 0.8 \cdot V_{CES}$ , $V_{GE} = 0V$<br>Note 3, $T_J = 125^\circ C$ |                       |            | 25 $\mu A$<br>4 mA |
| $I_{GES}$     | $V_{CE} = 0V$ , $V_{GE} = \pm 20V$  |                       |            | $\pm 100$ nA       |
| $V_{CE(sat)}$ | $I_C = 30A$ , $V_{GE} = 15V$ , Note 1<br>$T_J = 150^\circ C$                |                       | 3.5<br>4.6 | V<br>V             |

| Symbol Test Conditions<br>( $T_J = 25^\circ\text{C}$ Unless Otherwise Specified) |  | Characteristic Values |                    |                         |
|--|--|-----------------------|--------------------|-------------------------|
|  |  | Min.                  | Typ.               | Max.                    |
| $g_{fs}$   | $I_C = 30\text{A}, V_{CE} = 10\text{V}$ , Note 1   | 17                    | 28                 | S                       |
| $R_{Gi}$   | Gate Input Resistance  |                       | 2.8                | $\Omega$                |
| $C_{ies}$  | $V_{CE} = 25\text{V}, V_{GE} = 0\text{V}, f = 1\text{MHz}$   |                       | 3100               | pF                      |
| $C_{oes}$  |  |                       | 210                | pF                      |
| $C_{res}$  |  |                       | 55                 | pF                      |
| $Q_{g(on)}$  | $I_C = 30\text{A}, V_{GE} = 15\text{V}, V_{CE} = 0.5 \cdot V_{CES}$  |                       | 150                | nC                      |
| $Q_{ge}$   |  |                       | 15                 | nC                      |
| $Q_{gc}$   |  |                       | 65                 | nC                      |
| $t_{d(on)}$  | <b>Inductive load, <math>T_J = 25^\circ\text{C}</math></b><br>$I_C = 30\text{A}, V_{GE} = 15\text{V}$<br>$V_{CE} = 0.5 \cdot V_{CES}, R_G = 2.7\Omega$<br>Note 3 |                       | 16                 | ns                      |
| $t_{ri}$   |  |                       | 33                 | ns                      |
| $E_{on}$   |  |                       | 3.6                | mJ                      |
| $t_{d(off)}$   |  |                       | 143                | ns                      |
| $t_{fi}$   |  |                       | 95                 | ns                      |
| $E_{off}$  |  |                       | 1.8                | mJ                      |
| $R_{thJC}$   |  |                       |                    | 0.65 $^\circ\text{C/W}$ |
| $R_{thCS}$   |  | 0.15                  | $^\circ\text{C/W}$ |                         |



### Reverse Diode (FRED)

| Symbol Test Conditions<br>( $T_J = 25^\circ\text{C}$ , Unless Otherwise Specified) |   | Characteristic Value      |      |                         |
|--|---|---------------------------|------|-------------------------|
|  |   | Min.                      | Typ. | Max.                    |
| $V_F$  | $I_F = 30\text{A}, V_{GE} = 0\text{V}$ , Note 1   |                           |      | 3.5 V                   |
| $I_{RM}$   | $I_F = 30\text{A}, V_{GE} = 0\text{V}, -di_F/dt = 500\text{A}/\mu\text{s}$<br>$V_R = 1200\text{V}, T_J = 150^\circ\text{C}$ | $T_J = 150^\circ\text{C}$ | 3.7  | V                       |
| $t_{rr}$   |   |                           | 32   | A                       |
| $R_{thJC}$   |   |                           |      | 0.86 $^\circ\text{C/W}$ |

### Notes:

1. Pulse test,  $t \leq 300\mu\text{s}$ , duty cycle,  $d \leq 2\%$ .
2. Part must be heatsunk for high-temp  $I_{ces}$  measurement.
3. Switching times & energy losses may increase for higher  $V_{CE}$  (Clamp),  $T_J$  or  $R_G$ .

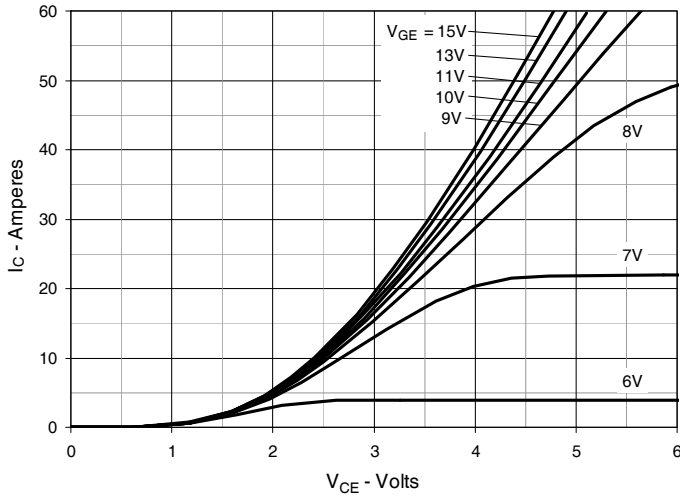
### ADVANCE TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

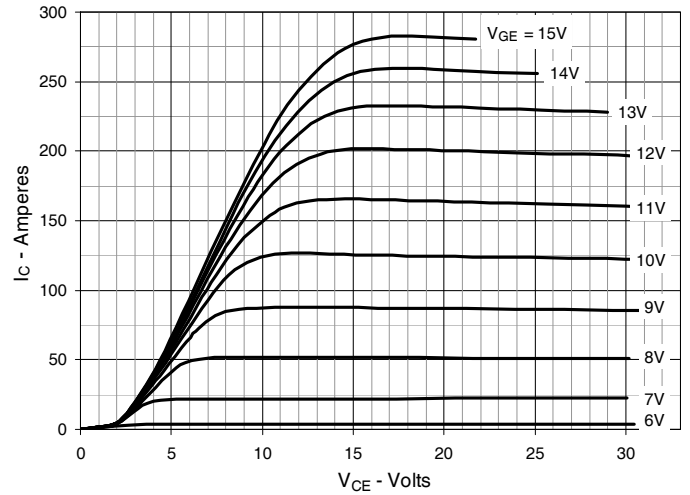
### IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.

|  |           |           |           |           |              |              |              |              |              |             |
|--|-----------|-----------|-----------|-----------|--------------|--------------|--------------|--------------|--------------|-------------|
| IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: | 4,835,592 | 4,931,844 | 5,049,961 | 5,237,481 | 6,162,665    | 6,404,065 B1 | 6,683,344    | 6,727,585    | 7,005,734 B2 | 7,157,338B2 |
|  | 4,860,072 | 5,017,508 | 5,063,307 | 5,381,025 | 6,259,123 B1 | 6,534,343    | 6,710,405 B2 | 6,759,692    | 7,063,975 B2 |             |
|  | 4,881,106 | 5,034,796 | 5,187,117 | 5,486,715 | 6,306,728 B1 | 6,583,505    | 6,710,463    | 6,771,478 B2 | 7,071,537    |             |

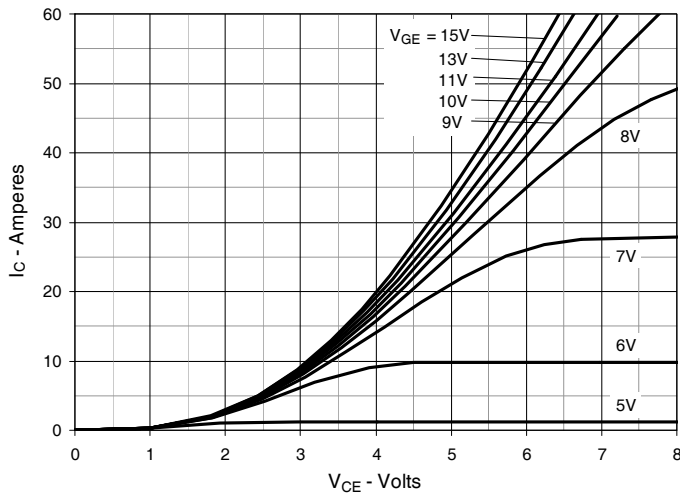
**Fig. 1. Output Characteristics @  $T_J = 25^\circ\text{C}$**



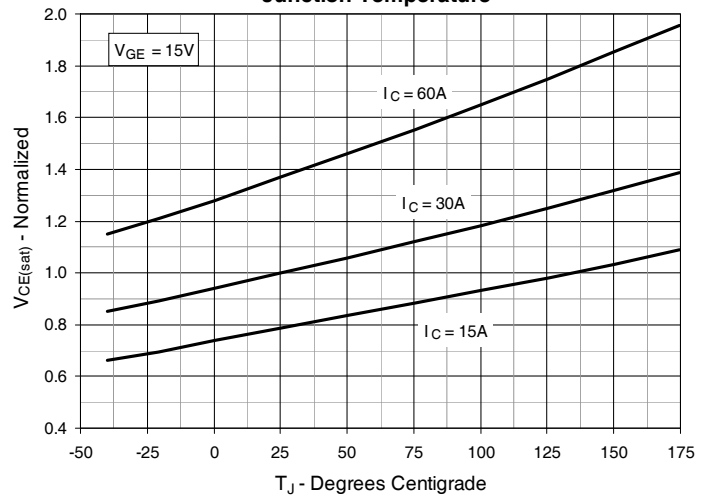
**Fig. 2. Extended Output Characteristics @  $T_J = 25^\circ\text{C}$**



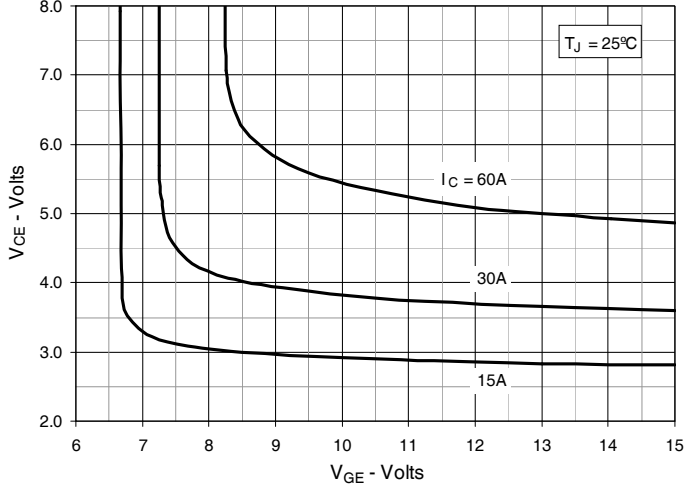
**Fig. 3. Output Characteristics @  $T_J = 150^\circ\text{C}$**



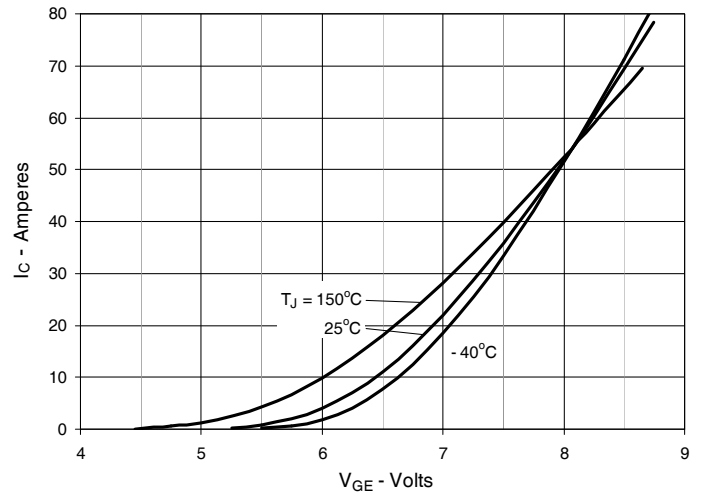
**Fig. 4. Dependence of  $V_{CE(sat)}$  on Junction Temperature**

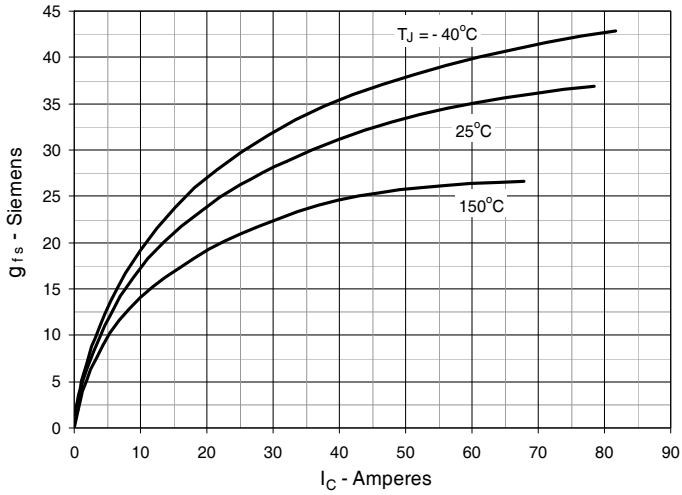
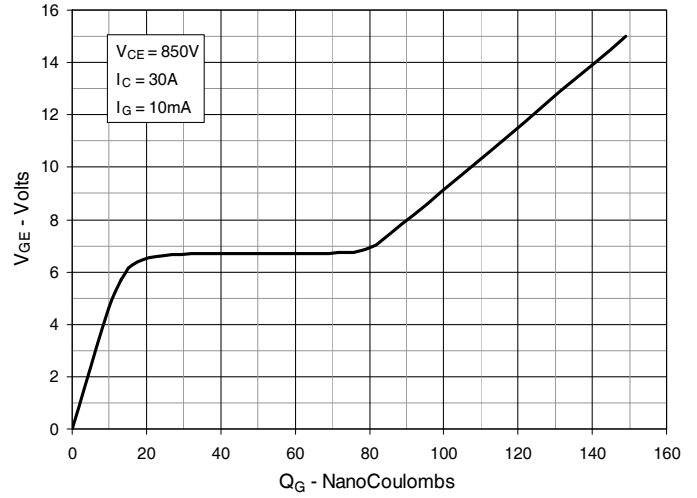
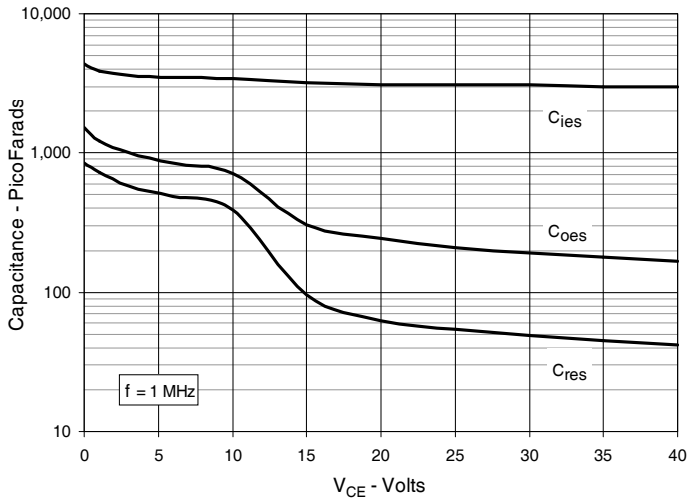
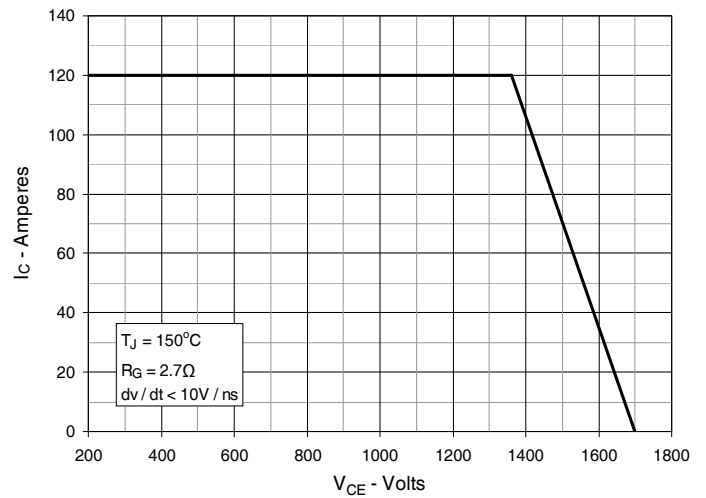
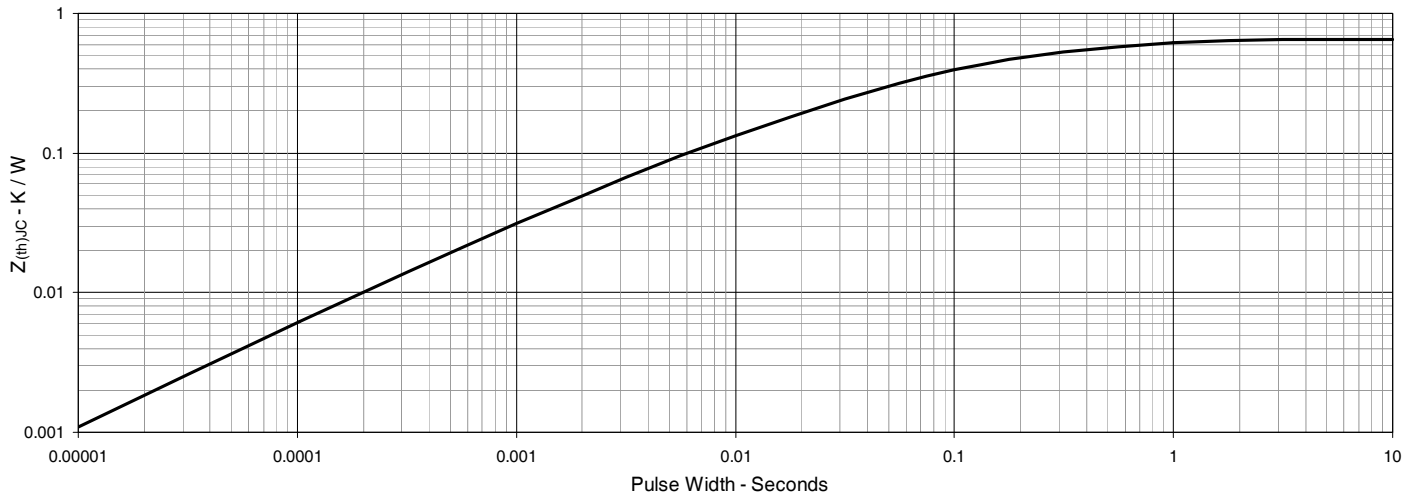


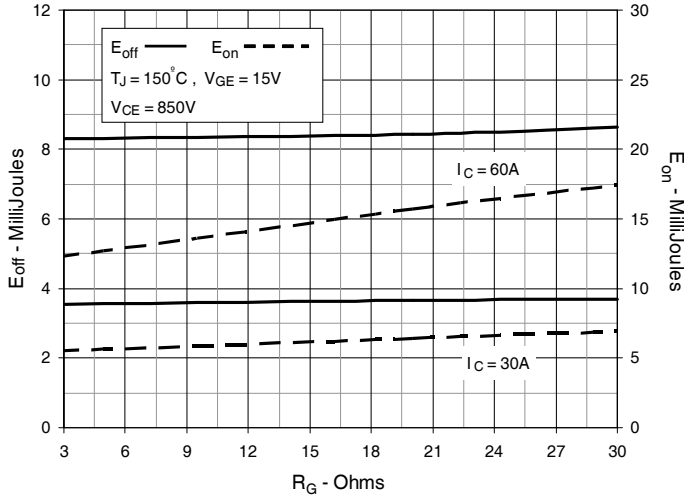
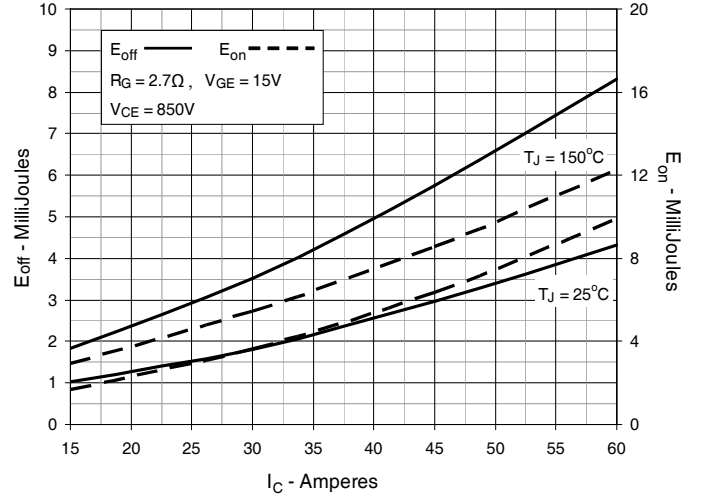
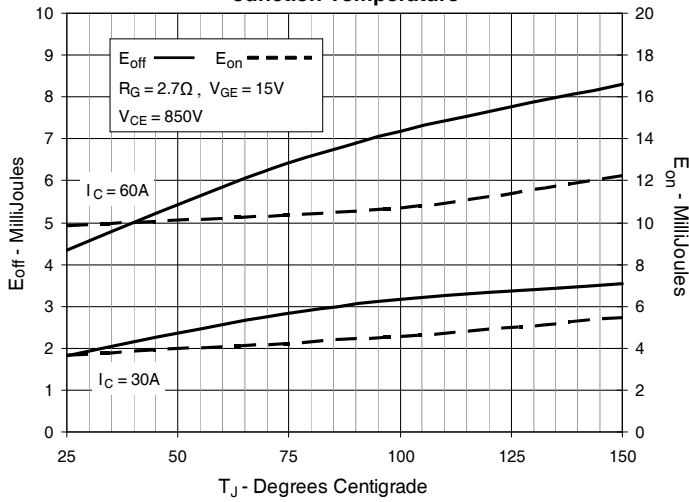
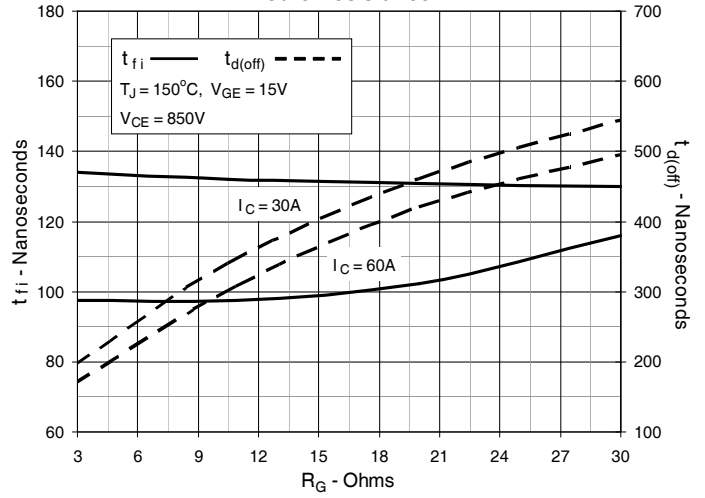
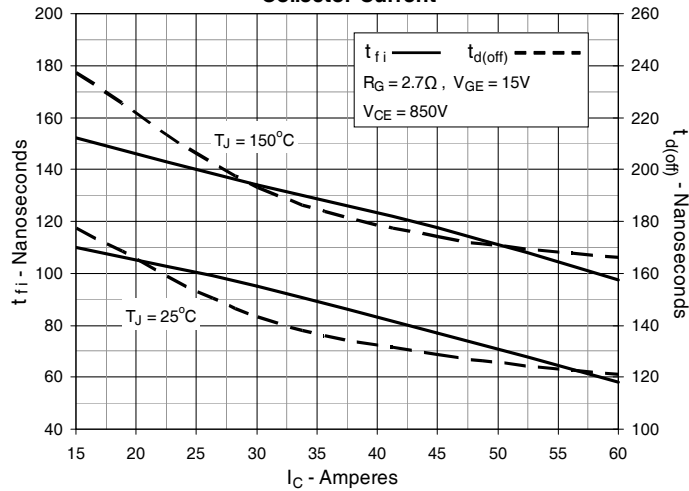
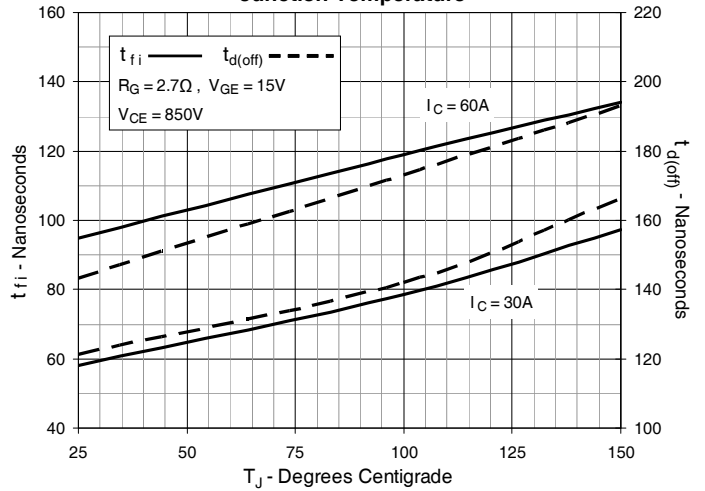
**Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage**



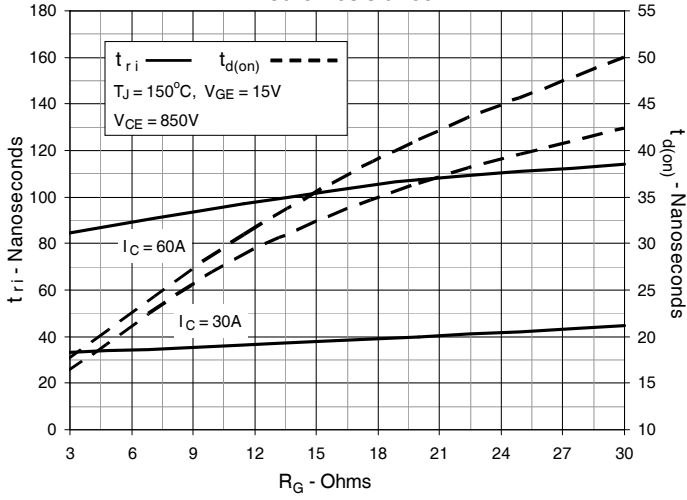
**Fig. 6. Input Admittance**



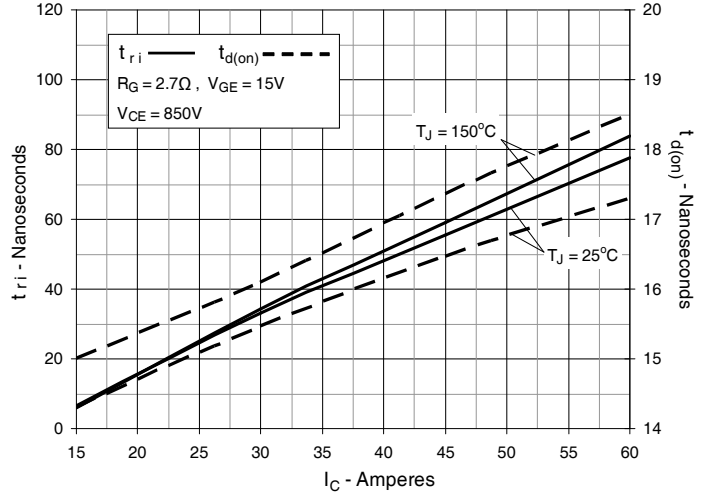
**Fig. 7. Transconductance**

**Fig. 8. Gate Charge**

**Fig. 9. Capacitance**

**Fig. 10. Reverse-Bias Safe Operating Area**

**Fig. 11. Maximum Transient Thermal Impedance (IGBT)**


**Fig. 12. Inductive Switching Energy Loss vs. Gate Resistance**

**Fig. 13. Inductive Switching Energy Loss vs. Collector Current**

**Fig. 14. Inductive Switching Energy Loss vs. Junction Temperature**

**Fig. 15. Inductive Turn-off Switching Times vs. Gate Resistance**

**Fig. 16. Inductive Turn-off Switching Times vs. Collector Current**

**Fig. 17. Inductive Turn-off Switching Times vs. Junction Temperature**


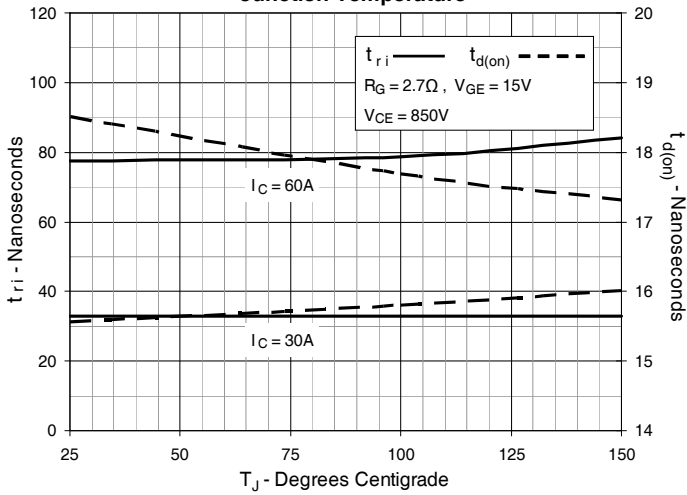
**Fig. 18. Inductive Turn-on Switching Times vs. Gate Resistance**

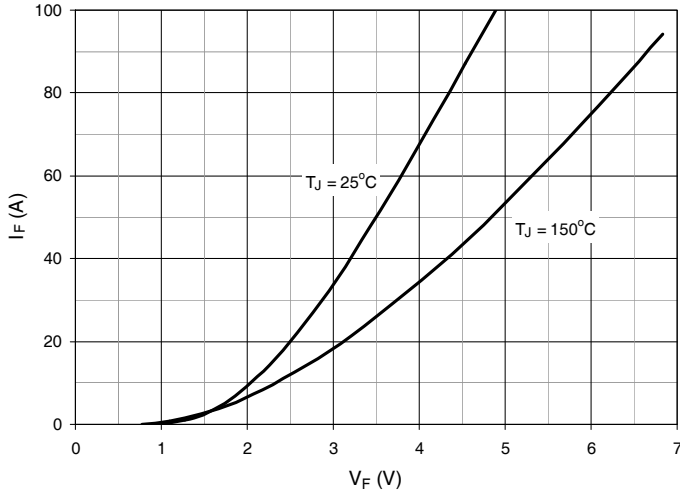
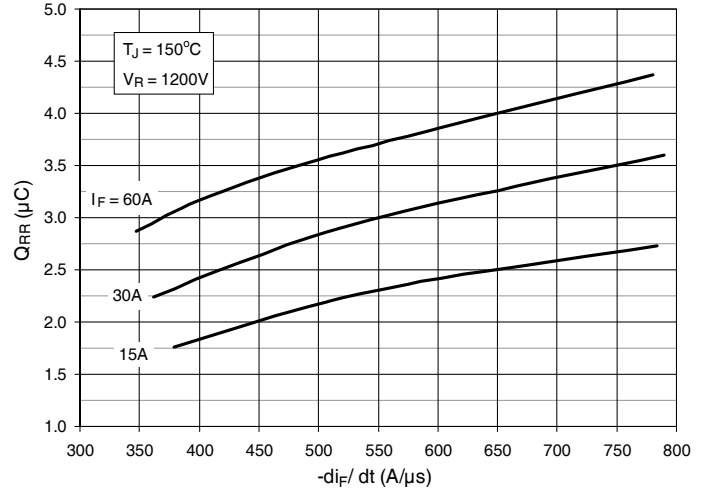
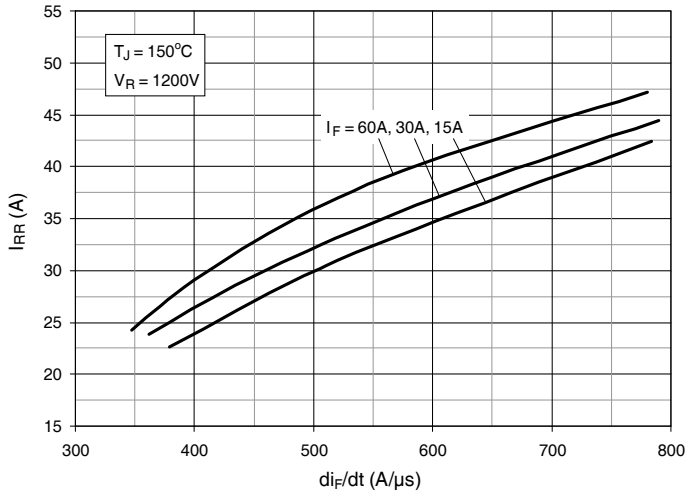
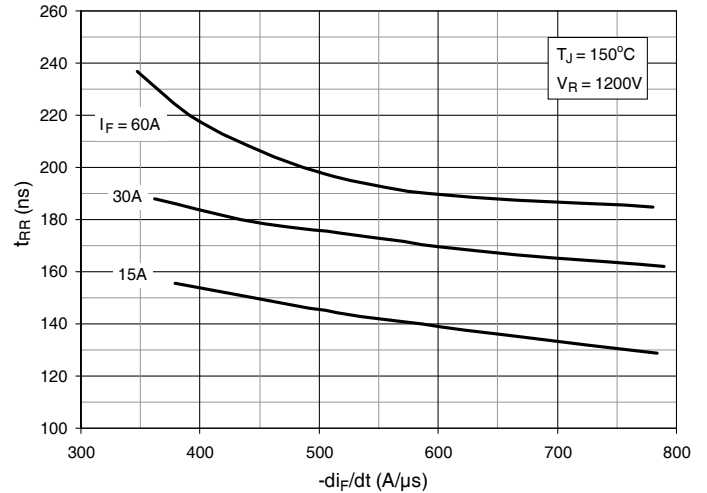
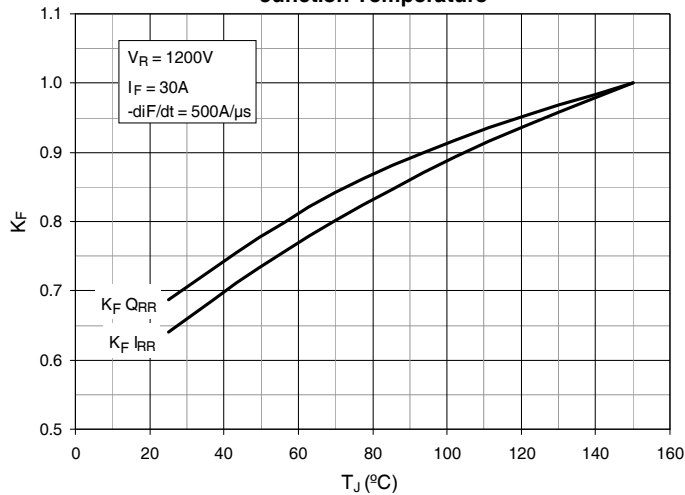
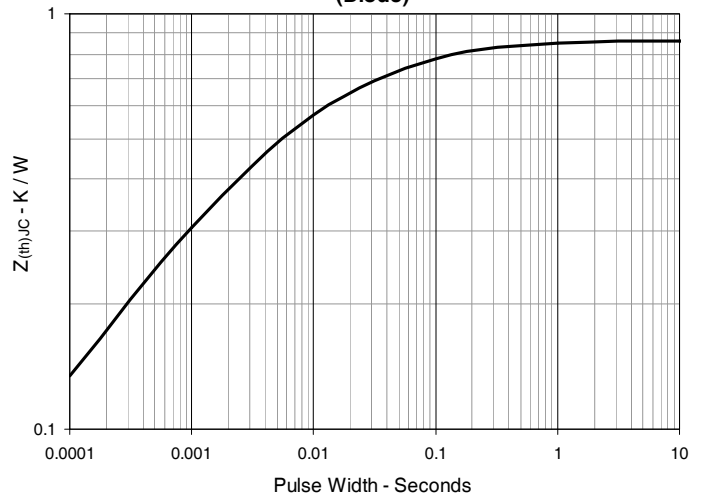


**Fig. 19. Inductive Turn-on Switching Times vs. Collector Current**



**Fig. 20. Inductive Turn-on Switching Times vs. Junction Temperature**



**Fig. 21. Diode Forward Characteristics**

**Fig. 22. Reverse Recovery Charge vs.  $-di_F/dt$** 

**Fig. 23. Reverse Recovery Current vs.  $-di_F/dt$** 

**Fig. 24. Reverse Recovery Time vs.  $-di_F/dt$** 

**Fig. 25. Dynamic Parameters  $Q_{RR}$ ,  $I_{RR}$  vs. Junction Temperature**

**Fig. 26. Maximum Transient Thermal Impedance (Diode)**




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